## ABSTRACT OF THE DISCLOSURE

There is provided a method in which a TFT with superior electrical characteristics is manufactured and high performance semiconductor device is realized by assembling a with the TFT. The method of manufacturing the circuit semiconductor device includes: a step of forming a crystalcontaining semiconductor film by carrying out a thermal annealing to a semiconductor film; a step of carrying out an oxidizing treatment to the crystal-containing semiconductor film; a step of carrying out a laser annealing treatment to the crystal-containing semiconductor film after the treatment has been carried out; and a step of carrying out a to the crystal-containing furnace annealing treatment semiconductor film after the laser annealing. The annealing treatment is carried out with an energy density of 250 to  $5000 \text{ mJ/cm}^2$ .

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